

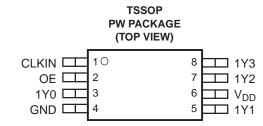
200-MHz GENERAL-PURPOSE CLOCK BUFFER, PCI-X COMPLIANT

Check for Samples: CDCV304

FEATURES

- General-Purpose and PCI-X 1:4 Clock Buffer
- Operating Frequency
 - 0 MHz to 200 MHz General-Purpose
- Low Output Skew: <100 ps
- Distributes One Clock Input to One Bank of Four Outputs
- Output Enable Control that Drives Outputs Low when OE is Low
- Operates from Single 3.3-V Supply or 2.5-V Supply

- PCI-X Compliant
- 8-Pin TSSOP Package



DESCRIPTION

The CDCV304 is a high-performance, low-skew, general-purpose PCI-X compliant clock buffer. It distributes one input clock signal (CLKIN) to the output clocks (1Y[0:3]). It is specifically designed for use with PCI-X applications. The CDCV304 operates at 3.3 V and 2.5 V and is therefore compliant to the 3.3-V PCI-X specifications.

The CDCV304 is characterized for operation from -40°C to 85°C for automotive and industrial applications.

FUNCTIONAL BLOCK DIAGRAM

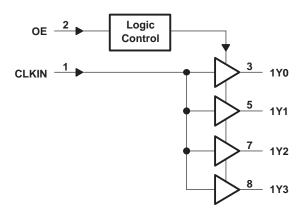


Table 1. FUNCTION TABLE

INP	OUTPUTS	
CLKIN	1Y[0:3]	
L	L	L
Н	L	L
L	Н	L
Н	Н	Н



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

TERMINAL FUNCTIONS

	TERMINAL	1/0	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
1Y[0:3]	3, 5, 7, 8	0	Buffered output clocks
CLKIN	1	I	Input reference frequency
GND	4	Power	Ground
OE	2	I	Output enable control
V_{DD}	6	Power	Supply

THERMAL INFORMATION(1)

	CDCV204DW 9 DIN TCCOD		THI	ERMAL AIF	R FLOW (C	FM)	UNIT
	CDCV304PW 8-PIN TSSOP			150	250	500	UNII
$R_{\theta JA}$	High K		149	142	138	132	
$R_{\theta JA}$	Low K		230	185	170	150	
$R_{\theta JB}$	High K	102.0					°C 111
R_{\thetaJC}	High K	43.7					°C/W
ΨJT	High K	1.8					
Ψ ЈВ	High K	100.2					

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) (1)

	UNIT
Supply voltage range, V _{DD}	–0.5 V to 4.3 V
Input voltage range, V _I (2) (3)	$-0.5 \text{ V to V}_{DD} + 0.5 \text{ V}$
Output voltage range, V _O ^{(2) (3)}	–0.5 V to V _{DD} + 0.5 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{DD})	±50 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{DD})	±50 mA
Continuous total output current, I _O (V _O = 0 to V _{DD})	±50 mA
Package thermal impedance, θ _{JA} : PW package	230.5°C/W
Storage temperature range T _{stg}	−65°C to 150°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) This value is limited to 4.6 V maximum.



RECOMMENDED OPERATING CONDITIONS

		MIN	NOM MAX	UNIT
Supply voltage, V _{DD}		2.3	3.6	V
Low-level input voltage, V _{IL}			0.3 x V _{DD}	V
High-level input voltage, V _{IH}		0.7 x V _{DD}		V
Input voltage, V _I		0	V_{DD}	V
High level evitant evinent I	V _{DD} = 2.5 V		-12	
High-level output current, I _{OH}	V _{DD} = 3.3 V		-24	mA
Lavidaval autout aumant 1	V _{DD} = 2.5 V		12	
Low-level output current, I _{OL}	$V_{DD} = 3.3 \text{ V}$		24	mA
Operating free-air temperature, T	ating free-air temperature, T _A –40 89		°C	

TIMING REQUIREMENTS

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{clk}	Clock frequency		0		200	MHz

ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CO	TEST CONDITIONS			MAX	UNIT
V_{IK}	Input voltage	$V_{DD} = 3 V$,	$I_1 = -18 \text{ mA}$			-1.2	V
		V _{DD} = 2.3 V,	$I_{OH} = -8 \text{ mA}$	1.8			
		$V_{DD} = 2.3 \text{ V},$	I _{OH} = -16 mA	1.5			
V_{OH}	High-level output voltage	$V_{DD} = min to max,$	$I_{OH} = -1 \text{ mA}$	V _{DD} – 0.2			V
		$V_{DD} = 3 V$,	$I_{OH} = -24 \text{ mA}$	2			
		$V_{DD} = 3 V$,	$I_{OH} = -12 \text{ mA}$	2.4			
		V _{DD} = 2.3 V,	I _{OL} = 8 mA			0.5	
	Low-level output voltage	$V_{DD} = 2.3 \text{ V},$	I _{OL} = 16 mA			0.7	V
V_{OL}		$V_{DD} = min to max,$	$I_{OL} = 1 \text{ mA}$			0.2	
		$V_{DD} = 3 V$,	$I_{OL} = 24 \text{ mA}$			8.0	
		$V_{DD} = 3 V$,	I_{OL} = 12 mA			0.55	
	High level output ourrent	$V_{DD} = 3 V$,	V _O = 1 V	-50			^
I _{OH}	High-level output current	$V_{DD} = 3.3 V,$	V _O = 1.65 V		– 55		mA
	I am laval antonit annout	V _{DD} = 3 V,	V _O = 2 V	60			A
l _{OL}	Low-level output current	$V_{DD} = 3.3 \text{ V},$	V _O = 1.65 V		70		mA
I _I	Input current	$V_I = V_O \text{ or } V_{DD}$				±5	μΑ
		f = 67 MHz,	V _{DD} = 2.7 V			28	A
I _{DD}	Dynamic current, see Figure 5	f = 67 MHz,	V _{DD} = 3.6 V			37	mA
Cı	Input capacitance	$V_{DD} = 3.3 \text{ V},$	$V_I = 0 \text{ V or } V_{DD}$		3		pF
Co	Output capacitance	$V_{DD} = 3.3 \text{ V},$	$V_I = 0 \text{ V or } V_{DD}$		3.2		pF

⁽¹⁾ All typical values are with respect to nominal V_{DD} and T_A = 25°C.

© 2000–2011, Texas Instruments Incorporated

SCAS643H - SEPTEMBER 2000 - REVISED FEBRUARY 2011



SWITCHING CHARACTERISTICS

 V_{DD} = 2.5 V ± 10%, C_L = 10 pF (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{PLH}	Low-to-high propagation delay	Con Figure 1 and Figure 2	2	2.9	4.5	20
t _{PHL}	High-to-low propagation delay	See Figure 1 and Figure 2	2	3	4.5	ns
t _{sk(o)}	Output skew ⁽²⁾	See Figure 3		50	150	ps
t _r	Output rise slew rate		1.5	2.2	4	V/ns
t _f	Output fall slew rate		1.5	2.2	4	V/ns

SWITCHING CHARACTERISTICS

 V_{DD} = 3.3 V ± 10%, C_L = 10 pF (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t _{PLH}	Low-to-high propagation delay	See Figure 4 and Figure 2	1.8	2.4	3	
t _{PHL}	High-to-low propagation delay	See Figure 1 and Figure 2	1.8	2.5	3	ns
t _{sk(o)}	Output skew ⁽²⁾			50	100	ps
	Additional bases iitteen formations at the contract AVO	12 kHz to 5 MHz, f _{out} = 30.72 MHz		63		f
t _{jitter}	Additive phase jitter from input to output 1Y0	12 kHz to 20 MHz, f _{out} = 125 MHz		56		fs rms
t _{sk(p)}	Pulse skew	$V_{IH} = V_{DD}, V_{IL} = 0 V$			150	ps
t _{sk(pr)}	Process skew			0.2	0.3	ns
t _{sk(pp)}	Part-to-part skew			0.25	0.4	ns
	Clash kink time and Figure 4	66 MHz	6			
t _{high}	Clock high time, see Figure 4	140 MHz	3			ns
	Clash law times and Figure 4	66 MHz	6			
t _{low}	Clock low time, see Figure 4	140 MHz	3			ns
t _r	Output rise slew rate ⁽³⁾	V _O = 0.4 V to 2 V	1.5	2.7	4	V/ns
t _f	Output fall slew rate ⁽³⁾	V _O = 2 V to 0.4 V	1.5	2.7	4	V/ns

All typical values are with respect to nominal V_{DD} . The $t_{sk(o)}$ specification is only valid for equal loading of all outputs.

 $[\]begin{array}{ll} \text{(1)} & \text{All typical values are with respect to nominal V_{DD}.} \\ \text{(2)} & \text{The $t_{sk(o)}$ specification is only valid for equal loading of all outputs.} \\ \text{(3)} & \text{This symbol is according to PCI-X terminology.} \end{array}$



PARAMETER MEASUREMENT INFORMATION

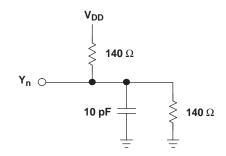


Figure 1. Test Load Circuit

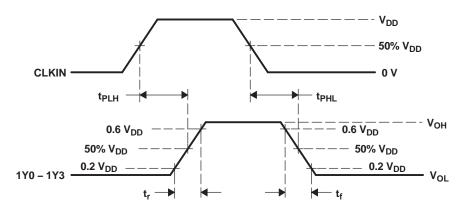


Figure 2. Voltage Waveforms Propagation Delay (tpd) Measurements

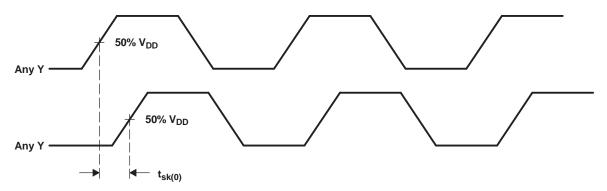
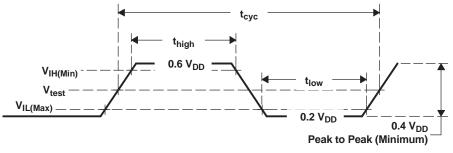


Figure 3. Output Skew

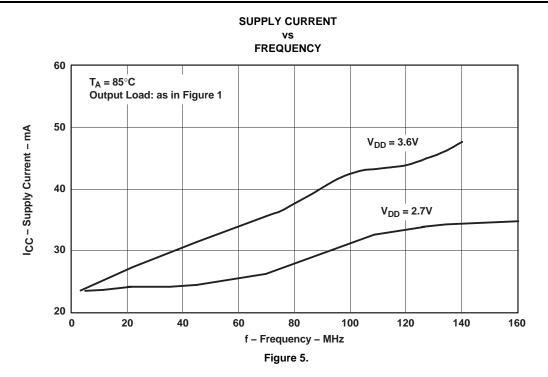
PARAMETER	VALUE	UNIT
V _{IH(Min)}	0.5 V _{DD}	V
V _{IL(Max)}	$0.35~\mathrm{V_{DD}}$	V
V _{test}	$0.4~\mathrm{V_{DD}}$	V



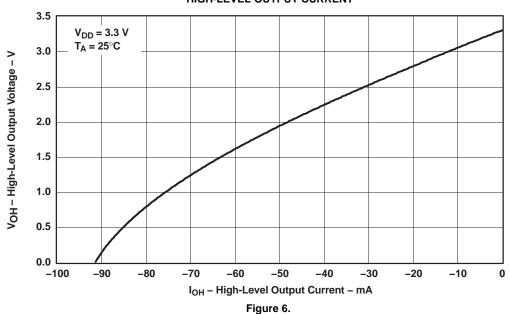
A. All parameters in Figure 4 are according to PCI-X 1.0 specifications.

Figure 4. Clock Waveform





HIGH-LEVEL OUTPUT VOLTAGE vs HIGH-LEVEL OUTPUT CURRENT





LOW-LEVEL OUTPUT VOLTAGE vs LOW-LEVEL OUTPUT CURRENT

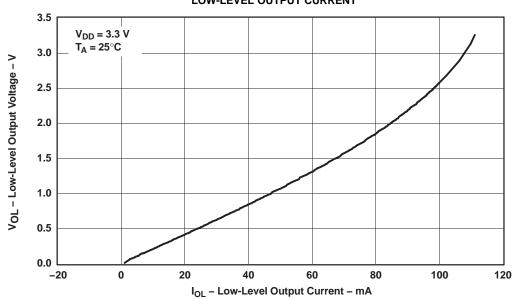


Figure 7.



REVISION HISTORY

C	hanges from Revision F (April 2009) to Revision G	Page
•	Added ψ _{JT} and ψ _{JB} specs to the Thermal Information Table and changed R _{θJB} and R _{θJC} specs from 65 and 69 °C/W respectively.	2
C	hanges from Revision G (January 2011) to Revision H	Page
	Added missing characteristics graphs.	6





11-Feb-2012

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CDCV304PW	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Add to cart
CDCV304PWG4	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Add to cart
CDCV304PWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Add to cart
CDCV304PWRG4	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	Add to cart

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

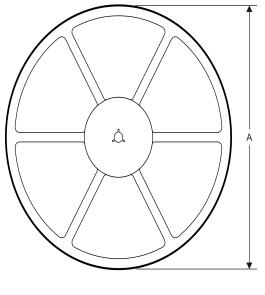
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

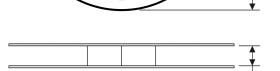
PACKAGE MATERIALS INFORMATION

www.ti.com 14-Jul-2012

TAPE AND REEL INFORMATION

REEL DIMENSIONS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCV304PWR	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 14-Jul-2012

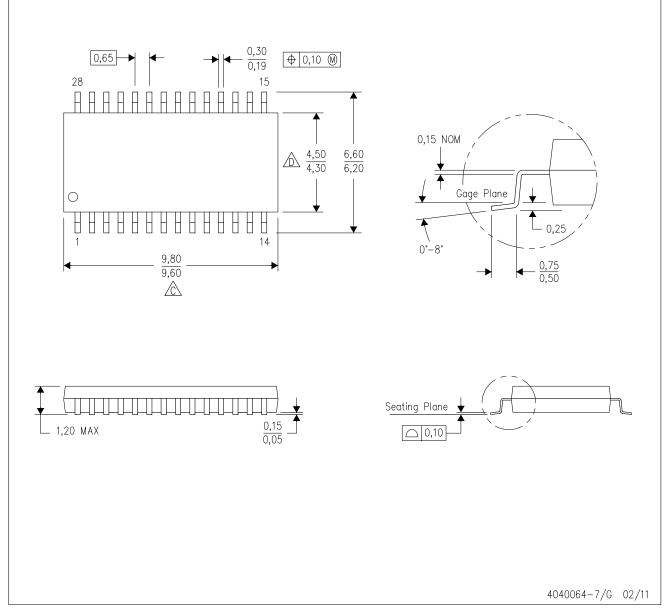


*All dimensions are nominal

I	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
I	CDCV304PWR	TSSOP	PW	8	2000	367.0	367.0	35.0

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



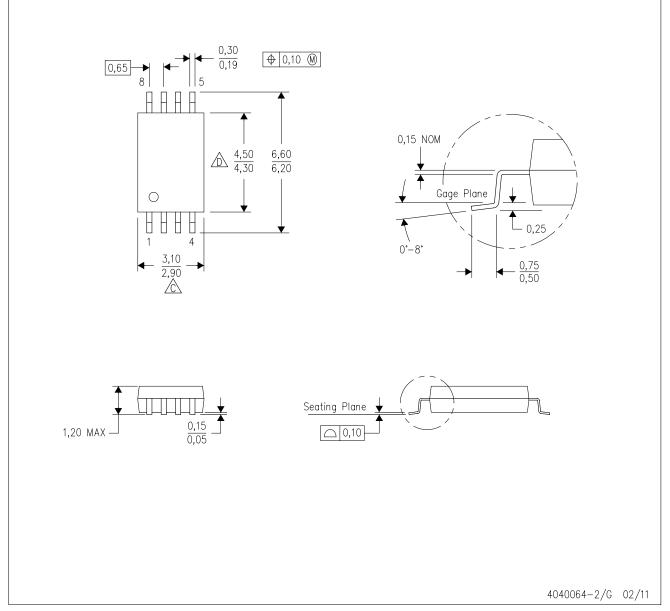
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46C and to discontinue any product or service per JESD48B. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

roducts		Applications
udia	ununu ti oom/oudio	Automotive on

Audio Automotive and Transportation www.ti.com/automotive www.ti.com/audio www.ti.com/communications **Amplifiers** amplifier.ti.com Communications and Telecom **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** Consumer Electronics www.ti.com/consumer-apps www.dlp.com DSP dsp.ti.com **Energy and Lighting** www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical Logic logic.ti.com Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

OMAP Mobile Processors www.ti.com/omap TI E2E Community e2e.ti.com

Wireless Connectivity www.ti.com/wirelessconnectivity

www.ti-rfid.com

Pr